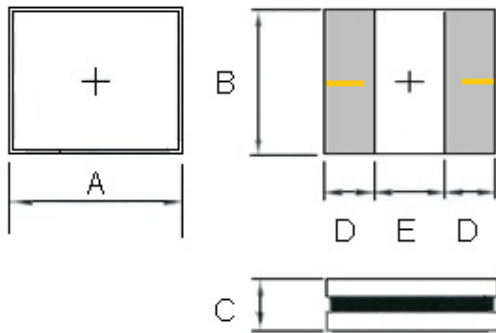


|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**PACKING DIMENSIONS (mm)**

| PHN252012 | Dimensions |
|-----------|------------|
| A         | 2.5 ± 0.3  |
| B         | 2.0 ± 0.35 |
| C         | 1.3 MAX    |
| D         | 0.85 REF   |
| E         | 0.80 REF   |

**EXPLANATION OF PART NUMBERS**

|   |   |   |    |    |    |   |   |   |    |    |   |
|---|---|---|----|----|----|---|---|---|----|----|---|
| 1 | 2 | 3 | 4  | 5  | 6  | 7 | 8 | 9 | 10 | 11 |   |
| P | H | N | 25 | 20 | 12 | T | - | 1 | R  | 0  | M |
|   | ① |   |    | ②  |    | ③ |   | ④ |    |    | ⑤ |

1. Product Name
2. Dimensions
3. Material
4. Inductance Code
5. Inductance Tolerance (N = 30% , M = 20%)

**ELECTRICAL CHARACTERISTICS**

| HUNGTRON<br>Part Number | Inductance<br>(uH) | Test Frequency<br>(Hz) | DCR<br>(Ω) typ. | DCR<br>(Ω) Max. | I sat<br>(A) typ. | I sat<br>(A) Max. | I rms<br>(A) typ | I rms<br>(A) Max. |
|-------------------------|--------------------|------------------------|-----------------|-----------------|-------------------|-------------------|------------------|-------------------|
| PHN252012T-R33□         | 0.33               | 1M                     | 0.022           | 0.032           | 6.80              | 6.5               | 4.7              | 4.3               |
| PHN252012T-R47□         | 0.47               | 1M                     | 0.025           | 0.035           | 6.30              | 6                 | 4.3              | 4                 |
| PHN252012T-1R0□         | 1                  | 1M                     | 0.047           | 0.055           | 4.80              | 4.5               | 3.5              | 3.2               |
| PHN252012T-1R5□         | 1.5                | 1M                     | 0.065           | 0.072           | 4.10              | 3.8               | 2.7              | 2.4               |
| PHN252012T-2R2□         | 2.2                | 1M                     | 0.09            | 0.108           | 3.30              | 3.1               | 2.4              | 2.3               |
| PHN252012T-3R3□         | 3.3                | 1M                     | 0.14            | 0.165           | 2.60              | 2.4               | 2.2              | 2                 |
| PHN252012T-4R7□         | 4.7                | 1M                     | 0.2             | 0.3             | 2.20              | 2.10              | 2.00             | 1.90              |
| PHN252012T-100□         | 10                 | 1M                     | 0.45            | 0.55            | 1.40              | 1.30              | 1.10             | 1.00              |

Storage temp. and humidity : -40 to +85°C ,70%RH max

**Note :**

- When ordering please specify tolerance and packaging codes.
- L:Agilent/HP4291B+Agilent/HP16197A, 1MHz/200mV
- RDC:Digital Milliohm Meter Agilent/HP4338B
- Isat & Irms : Microtest 6377, 1MHz/200mV
- Isat & Irms : Microtest 6377, 1MHz/200mV

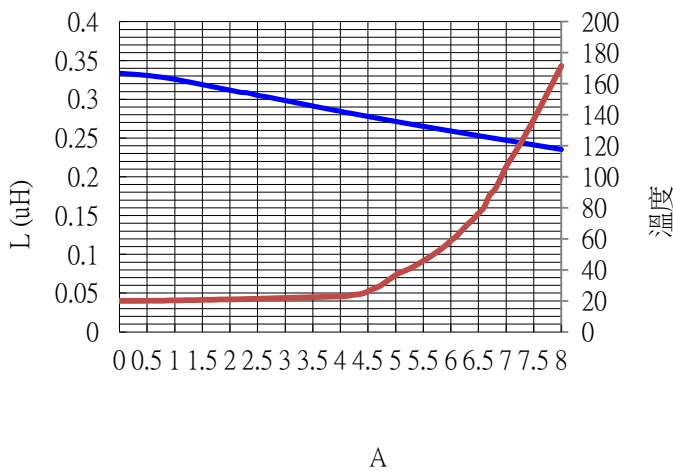
|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**Note :**

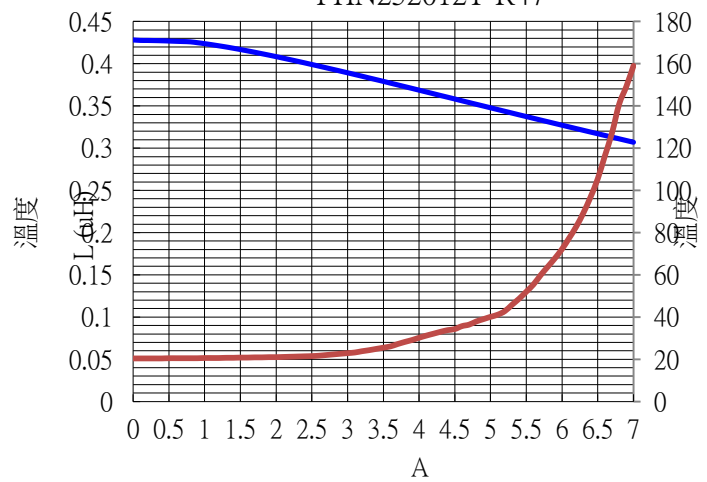
- Isat for Inductance drop 30% from its value without current typical.
- Irms for a 40°C rise above 25°C ambient typical.
- If Use wave soldering is there will be some risk.(Crack · unwitting& Mark Shed)
- Re-flow soldering temperatures below 240 degrees,there will be unwitting risk
- Operating Temperature Range -40°C to +125°C(Including self-temperature rise)
- When total area of exposed wire occurring to each sides is not greater than 75% of coating resin area, that is acceptable.

**PERFORMANCE CURVES**

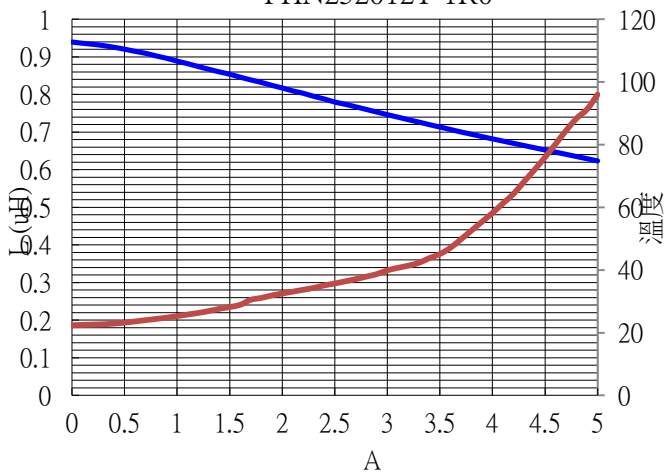
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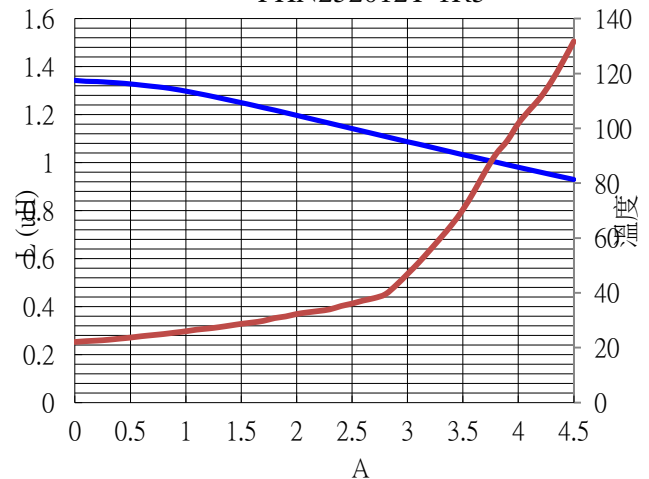
PHN252012T-R47



PHN252012T-1R0

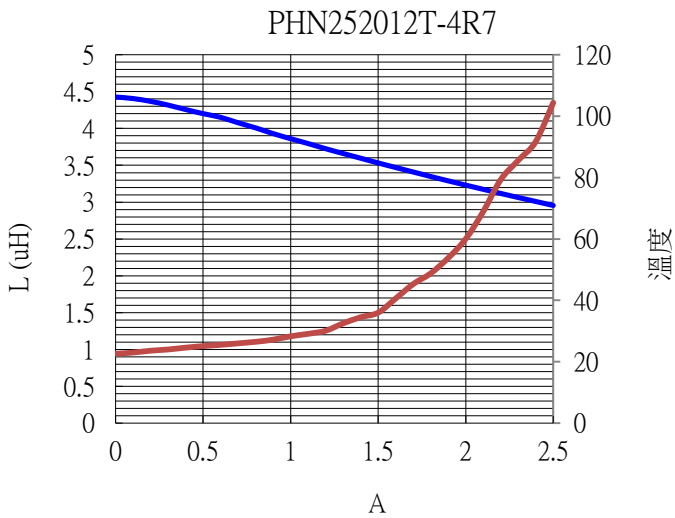
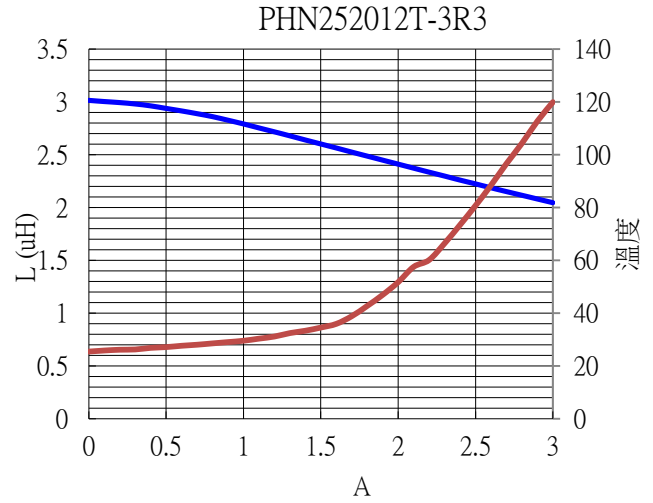
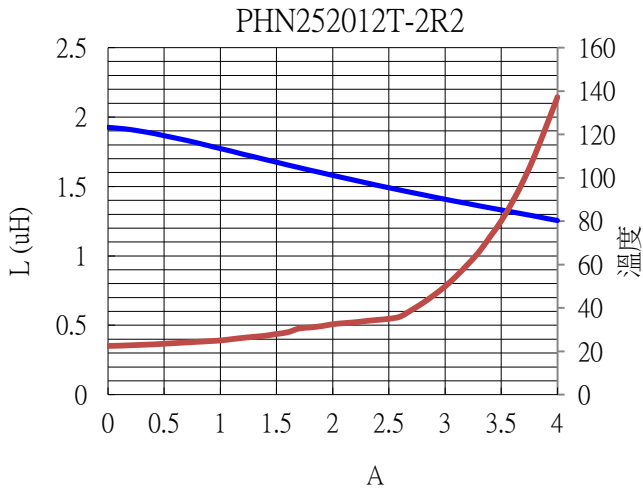


PHN252012T-1R5

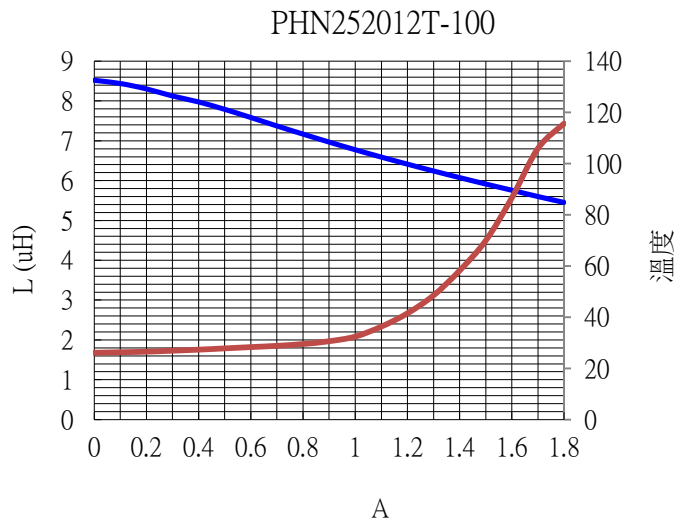


|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

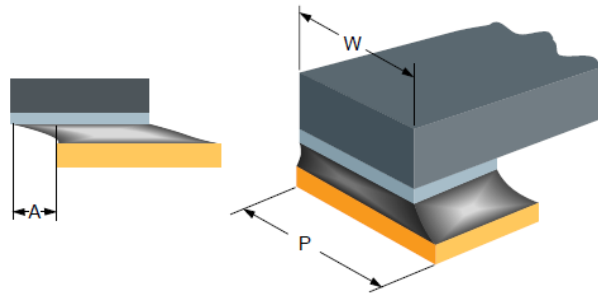
## PERFORMANCE CURVES



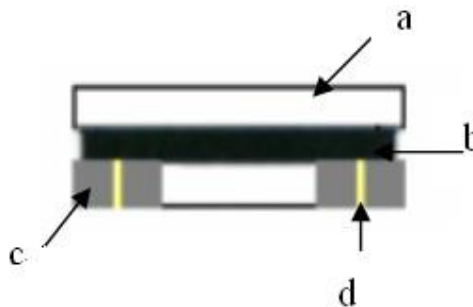
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|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**PERFORMANCE CURVES****Overhang acceptance description**

Side overhang (A) is less than or equal to 20% width of component termination area (W) or 20% width of land (P),

**Material List**

| No. | Description | Specification        |
|-----|-------------|----------------------|
| a.  | Core        | Metal Core           |
| b.  | Coating     | Epoxy                |
| c.  | Termination | Ti Pb Free           |
| d.  | Wire        | Enameled Copper Wire |



|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**Reliability and Test Condition**

| Item                  | Performance                                  | Test Condition |
|-----------------------|--|----------------|
| Operating Temperature | -40~+105°C (Including self-temperature rise) |                |

**Electrical Performance Test**

|                       |  |   |
|-----------------------|--|---|
| Inductance L          | Refer to standard electrical characteristic list | Agilent-4291, Agilent-4287<br>Agilent-4192, Agilent-4285  |
| Q                     |  |   |
| SRF                   |  | Agilent-4291  |
| DC Resistance         |  | Agilent-4338  |
| Rated Current         | Base on temp. rise & $\Delta L/LOA \leq 30\%$ .  | Saturation DC Current (Isat) will cause LO to drop approximately $\Delta L(\%)$ .   |
| Temperature Rise Test | $\Delta T$ 40°C Max                              | Heat Rated Current (Irms) Will cause the coil temperature rise approximately $\Delta T(^{\circ}C)$ without core loss.<br>1. Applied the allowed DC current.<br>2. Temperature measured by digital surface thermometer |

**Mechanical Performance Test**

|   |  |   |
|---|--|---|
| Resistance to Soldering Heat<br>MIL-STD-202<br>METHOD 210 | 1. Inductors shall be no evidence of electrical and mechanical damage.<br>2. Inductance : within $\pm 10\%$ of initial value | Temp.: 260 $\pm$ 5°C<br>Time: 10 $\pm$ 1.0 Sec  |
| Solderability Test<br>ANSI/J-STD-002                      | More than 95% of terminal electrode should be covered with solder.   | <p>After fluxing, component shall be dipped in a melted solder bath at 235<math>\pm</math>5°C for 4<math>\pm</math>1 seconds.</p> |

|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**Reliability and Test Condition**

| Item   | Performance   | Test Condition   |                 |             |   |       |      |   |      |         |   |      |      |   |
|--|---|--|-----------------|-------------|---|-------|------|---|------|---------|---|------|------|---|
| <b>Reliability Test</b>  |   |  |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>Humidity Test</b><br>MIL-S TD-202<br>METHOD 103             |   | 1. Temperature : 40±2°C<br>2. Humidity : 90 ~ 95%<br>3. Time : 500 ±8hrs<br>4. Measured at room temperature after placing for 2 to 3 hrs   |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>Thermal Shock Test</b><br>MIL-S TD-202<br>METHOD 107        | 1. Visual examination : No mechanical damage<br>2. Inductance : within±10% of initial value   |  |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>High Temperature Life Test</b><br>MIL-STD-202<br>METHOD 108 |   | 1. Temperature : 85±2°C<br>2. Time : 500±8hrs<br>3. Measured at room temperature after placing for 2to3 hrs  |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>Humidity Resistance Test</b><br>MIL-S TD-202<br>METHOD 103  | <p>Conditions for 1 cycle</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> <th>Times(min.)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>-55±2</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room</td> <td>Within5</td> </tr> <tr> <td>2</td> <td>85±5</td> <td>30±3</td> </tr> </tbody> </table> <p>Total: 100 cycles<br/>Measured at room temperature after placing for 2 to 3 hrs</p> | Step   | Temperature(°C) | Times(min.) | 1 | -55±2 | 30±3 | 2 | Room | Within5 | 2 | 85±5 | 30±3 | Temperature: 40±2°C<br>Humidity: 90~ 95%<br>3. Time: 500±8hr.<br>4. Recovery: 2 to 3hrs of recovery under the standard condition after the removal from test chamber. |
| Step   | Temperature(°C)   | Times(min.)  |                 |             |   |       |      |   |      |         |   |      |      |   |
| 1  | -55±2   | 30±3   |                 |             |   |       |      |   |      |         |   |      |      |   |
| 2  | Room  | Within5  |                 |             |   |       |      |   |      |         |   |      |      |   |
| 2  | 85±5  | 30±3   |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>Low temperature Storage Test</b><br>JE SD22-A119            |   | 1. Temperature : -40±2°C<br>2. Time : 500±8hrs<br>3. Measured at room temperature after placing for 2to3 hrs   |                 |             |   |       |      |   |      |         |   |      |      |   |
| <b>Random Vibration Test</b><br>MIL-S TD-202<br>Method 204     | Appearance: Cracking, shipping and any other defects harmful to the characteristics should not be allowed.<br>Inductance : within±10%   | Frequency: 10-55-10Hz for 15 min.<br>Amplitude: 1.52mm<br>Directions and times: X, Y, Z directions for 15 min. This cycle shall be performed 12 times in each of three mutually perpendicular directions (Total 9hours). |                 |             |   |       |      |   |      |         |   |      |      |   |

|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

## Soldering and Mounting

### Soldering

Mildly activated rosin fluxes are preferred. terminations are suitable for re-flow soldering systems.  
If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

### Solder re-flow:

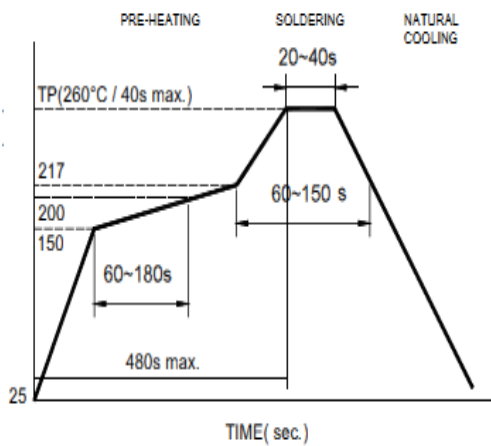
Recommended temperature profiles for re-flow soldering in Figure 1.

### Soldering Iron(Figure 2):

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 355°C tip temperature (max)
- 1.0mm tip diameter (max)

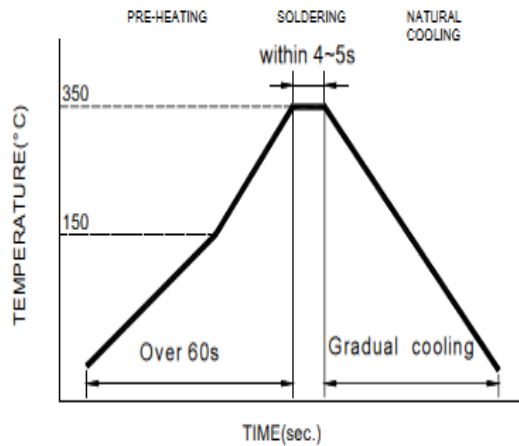
Reflow Soldering



Reflow times: 3 times max.

Fig.1

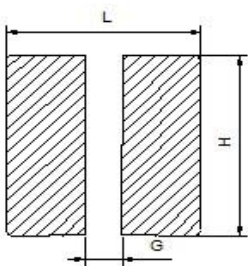
Iron Soldering



Iron Soldering times: 1 times max.

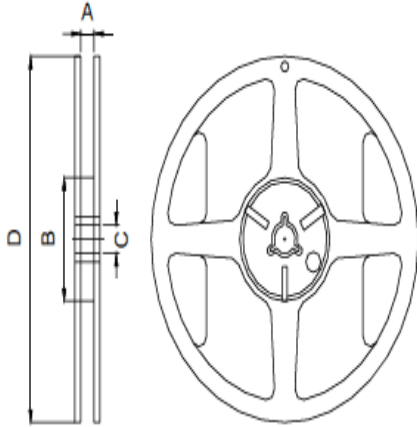
Fig.2

## Recommended PC Board Pattern



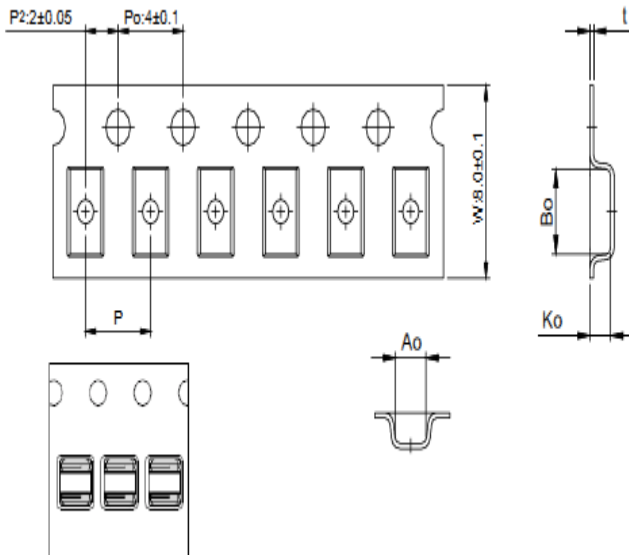
| L(mm) | G(mm) | H(mm) |
|-------|-------|-------|
| 2.7   | 0.8   | 2.2   |

|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**Packaging Information****Reel Dimension**

7"x8mm

| Type   | A(mm)   | B(mm)   | C(mm)  | D(mm) |
|--------|---------|---------|--------|-------|
| 7"x8mm | 8.4±1.0 | 50 min. | 13±0.8 | 178±2 |



Bottom View

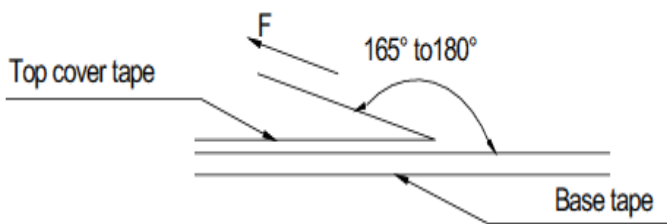
| Series | Size   | Bo(mm)   | Ao(mm)   | Ko(mm)   | P(mm)   | t(mm)     |
|--------|--------|----------|----------|----------|---------|-----------|
| PIN    | 252012 | 2.85±0.1 | 2.40±0.1 | 1.35±0.1 | 4.0±0.1 | 0.23±0.05 |



|          |                   |                 |                             |
|----------|-------------------|-----------------|-----------------------------|
| ITEM P/N | PHN252012T-SERIES | TEST INSTRUMENT | Agilent4291B / Agilent4338B |
| PRODUCT  | Power Inductor    | TEST FREQUENCY  | 1 MHz / 0.2V                |

**Packaging Information****Packaging Quantity**

|             |        |
|-------------|--------|
| Chip size   | 252012 |
| Chip / Reel | 2000   |

**Tearing Off Force**

The force for tearing off cover tape is 15 to 80 grams in the arrow direction under the following conditions.

| Room Temp.<br>(°C) | Room Humidity<br>(%) | Room atm<br>(hPa) | Tearing Speed<br>mm/min |
|--------------------|----------------------|-------------------|-------------------------|
| 5-35               | 45-85                | 860-1060          | 300                     |

- **Storage Conditions**

To maintain the solderability of terminal electrodes:

1. products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
2. Temperature and humidity conditions: Less than 40°C and 60% RH.
3. Recommended products should be used within 12 months form the time of delivery.
4. The packaging material should be kept where no chlorine or sulfur exists in the air.

- **Transportation**

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.